Issue Classification

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/David R. Hudspeth/

(Primary Examiner)

Samuel G Neway

Application/Control No.	Applicant(s)/Patent Under Reexamination								
10666815	CHEN ET AL.								
Examiner	Art Unit								

2626

ORIGINAL						INTERNATIONAL CLASSIFICATION											
CLASS SUBCL				SUBCLASS		CLAIMED						NON-CLAIMED					
704			8			G	0	6	F	17 / 20 (2006.0	.01)						
CROSS REFERENCE(S)			G	0	6	F	17 / 27 (2006.0 ⁻	.01)									
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/Samuel G Neway/ 06/20/2008											Total Claims Allowed:						
(Assistant Examiner) (Date)													17				

6/20/08

(Date)

O.G. Print Claim(s)

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O.G. Print Figure

3